| Search Notes | | | |
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| Application/Control No. | Applicant(s)/Patent under Reexamination | |
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| 10/647,107 | ISHIDA ET AL. | |
| Examiner | Art Unit | |
| Jim Vannucci | 2828 | |

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| Subclass | Date | Examiner | |
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| SEARCH NOT (INCLUDING SEARCH | |) |
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| | DATE | EXMR |
| fluorescent, semiconductor, particles | 8/17/2005 | JV |
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